

PRINTER RUSH
(PTO ASSISTANCE)

IFW

Application : 10/646172 Examiner : BASIC HAS GAU : 3749
From : OF Location : IDC FMF FDC Date : 11-22-04

Tracking #: 6025-401 Week Date: 10-18-04

DOC CODE	DOC DATE	MISCELLANEOUS
<input checked="" type="checkbox"/> 1449	<u>7-13-2004</u>	<input type="checkbox"/> Continuing Data
<input type="checkbox"/> IDS		<input type="checkbox"/> Foreign Priority
<input type="checkbox"/> CLM		<input type="checkbox"/> Document Legibility
<input type="checkbox"/> IIFW		<input type="checkbox"/> Fees
<input type="checkbox"/> SRFW		<input type="checkbox"/> Other
<input type="checkbox"/> DRW		
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[RUSH] MESSAGE: please verify name, date
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REV 10/04

Form PTO-1449

Attorney Docket No.
271303-1011Serial No.
10/646,172

INFORMATION DISCLOSURE CITATION

Applicant
Susumu MATSUYAMAFiling Date
August 22, 2003Group
3749

DEC 29 2003

(Use several sheets if necessary)

U.S. PATENT DOCUMENTS

Examiner Initials	Item	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
AB	A	9,843	08/1881	Woods et al.			
	B	213,052	03/1879	Lubin			02/13/1879
	C	241,298	05/1881	Carnahan			03/10/1881
	D	403,151	05/1889	Siemang et al.			01/12/1888
	E	467,736	01/1892	Fernelmont et al.			03/21/1891
	F	585,822	07/1897	Larwill et al.			04/04/1895
	G	959,804	05/1910	Purdy			01/03/1910
	H	1,037,948	09/1912	Mangin			03/28/1912
AB	I	3,516,774	06/1970	Livingstone	431	333	06/205/1968

FOREIGN PATENT DOCUMENTS

	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No
	O						
	P						
	Q						

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

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S	

* EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

EXAMINER'S SIGNATURE:

ALFRED BASICHAS
PRIMARY EXAMINER

DATE CONSIDERED:

7/9/04

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